

PACKAGE 82

SIMULTANEOUS CV PACKAGE

ANALYSIS CAPABILITIES

CONSTANTS: Flatband C and V
Threshold Voltage
Bulk Doping
Effective Oxide Charge
Work Function
Doping Type
'Best Depth'

GRAPHICS:

Measured: Simultaneous C vs. Gate Voltage
High Frequency C vs. Gate Voltage
Quasistatic C vs. Gate Voltage
Conductance vs. Gate Voltage
Q/t Current vs. Gate Voltage
Quasistatic C and Q/t Current vs. Delay Time

Calculated: Interface Trap Density vs. Trap Energy
Doping vs. Depletion Depth
Depletion Depth vs. Gate Voltage
High Frequency $1/C^2$ vs. Gate Voltage
Band Bending vs. Gate Voltage
High Frequency C vs. Band Bending
Quasistatic C vs. Band Bending

VOLTAGE MEASUREMENT

ACCURACY (1 Year, 18°-28°C): $\pm(0.05\% \text{ rdg} + 50\text{mV})$.
RESOLUTION: 10mV.
TEMPERATURE COEFFICIENT (0°-18° & 28°-40°C): $\pm(0.005\% + 1\text{mV})/^\circ\text{C}$.

VOLTAGE SOURCE

VOLTAGE	P-F NOISE ¹ (0.1 Hz to 10 Hz)	RESOLUTION
$\leq 20 \text{ V}$	150 μV	10 mV
$> 20 \text{ V to } 120 \text{ V}$	250 μV	100 mV

¹Typically 3 mV up to 75 MHz.

MAXIMUM SWEEP SPAN, $|V_{\text{START}} - V_{\text{STOP}}|$: 40V.
MAXIMUM OUTPUT CURRENT: $\pm 2\text{mA}$ (-0%, +20%).
SWEEP STEP VOLTAGE SELECTIONS: 10mV, 20mV, 50mV, 100mV.
DC OUTPUT RESISTANCE: <100.

GENERAL

READING RATES: 4½ readings per second to one reading every 400 seconds.
DATA BUFFER: 1000 points maximum.
GRAPHICAL OUTPUTS: Computer display or digital plotter supporting HPGL with IEEE-488 interface; also "screen copy" to compatible printer.
DIGITAL I/O: Consists of one output, four inputs, +5V (series limited with 330), and COMMON referenced to IEEE-488 COMMON. Output will drive one TTL load. Inputs represent one TTL load.
MAXIMUM INPUT: 30V peak, dc to 60Hz sine wave.
MAXIMUM COMMON MODE VOLTAGE: 30V maximum, dc to 60Hz sine wave.
OPERATING ENVIRONMENT: 0° to 40°C, 70% non-condensing RH up to 35°C.
STORAGE ENVIRONMENT: -25° to +65°C.

HIGH FREQUENCY CAPACITANCE*

RANGE	RESOLUTION	ACCURACY (1 Year, 18°-28°C) $\pm(\% \text{ rdg} + \text{pF})$	TEMPERATURE COEFFICIENT (0°-18° & 28°-40°C) $\pm(\% \text{ rdg})/^\circ\text{C}$	NOISE P-P
200 pF	10 fF	0.7 + 0.05	0.03	180 fF
2 nF	100 fF	0.9 + 0.5	0.08	1800 fF

RANGE	RESOLUTION	ACCURACY (1 Year, 18°-28°C) $\pm(\% \text{ rdg} + \text{pF})$	TEMPERATURE COEFFICIENT (0°-18° & 28°-40°C) $\pm(\% \text{ rdg})/^\circ\text{C}$	NOISE P-P
200 pF	10 fF	0.9 + 0.05	0.03	200 fF
2 nF	100 fF	1.4 + 0.5	0.14	400 fF

SHUNT CAPACITANCE LOADING EFFECT: 0.1% of reading additional error per 100pF load with equal shunt load on input and output.

TEST VOLTAGE: 15mV rms $\pm 10\%$.
TEST FREQUENCY TOLERANCE: $\pm 0.1\%$.

QUASISTATIC CAPACITANCE*

RANGE	RESOLUTION	ACCURACY (1 Year, 18°-28°C) $\pm(\% \text{ rdg} + \text{pF})$	NOISE P-P (typical)
200 pF	10 fF	1.0 + 0.1	$(0.12\% \text{ rdg} + 0.13 \text{ pF}) \times (100 \text{ mV/STEP V}) + 0.01 \text{ pF}$
2 nF	100 fF	0.8 + 0.2	$(0.09\% \text{ rdg} + 0.13 \text{ pF}) \times (100 \text{ mV/STEP V}) + 0.1 \text{ pF}$

TEMPERATURE COEFFICIENT (0°-18° & 28°-40°C): $\pm(0.02\% \text{ rdg} + 0.1 \text{ pF})/^\circ\text{C}$.

*NOTES

Specifications are based on parallel RC model and Quality Factor ≥ 20 . Assumes proper cable correction and open circuit suppression.
Quasistatic capacitance accuracy is exclusive of noise, for STEP V $\geq 0.05\text{V}$ and DELAY TIME ≤ 1 second. For other parameters, derate by $(5\text{mV/STEP V}) \times (\text{DELAY TIME}/1 \text{ second})$ in pF at 23°C. Double the derating for every 10°C rise in ambient temperature above 23°C.
Typical allowable non-equilibrium current plus leakage current: <20pA on 200pF range; <200pA on 2nF range during capacitance measurements.

WARMUP: 2 hours to rated accuracy.

SYSTEM CONFIGURATION: Models 230-1, 590, 595, and 5951 connected as shown in manual. Controller is HP Series 200 or 300 with BASIC 4.0. (requires 1 Mbyte of memory) or HP BASIC Language Processor Card in AT compatible computer.

PACKAGE 82 COMPONENTS:

- Model 230-1: Programmable Voltage Source
- Model 595: Quasistatic CV Meter
- Model 590: 100k/1M CV Analyzer
- Model 5909: Calibration Sources
- Model 5956: Package 82 CV Software and Manual
- Model 5951: Remote Input Coupler—includes Models:
 - 4801: Low Noise BNC Cable, 1.2m (4 ft.) (5 supplied)
 - 7007-1: Shielded IEEE-488 Cable, 1m (3.3 ft.) (2 supplied)
 - 7007-2: Shielded IEEE-488 Cable, 2m (6.6 ft.) (1 supplied)
 - 7051-2: RG-58C BNC to BNC Cable, 0.6m (2 ft.) (3 supplied)

Prices and specifications subject to change without notice.

PART NUMBER
SPEC. 82

LTR	REVISIONS	APP.	DATE	DRN.	DATE
B	REDRAWN #F12892		7-14-88	D. J.	7-14-88
				CKD.	DATE
				APP.	DATE

KEITHLEY Keithley Instruments Inc.
Cleveland, Ohio 44139

SPECIFICATIONS

PART NUMBER
SPEC. 82

BRUNING 40-21 62198

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DC OUTPUT RESISTANCE: < 100 .

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DATA BUFFER: 1000 points maximum.

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			COEFFICIENT (0°-18° & 28°-40°C) $\pm(\% \text{ rdg})/^{\circ}\text{C}$	
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